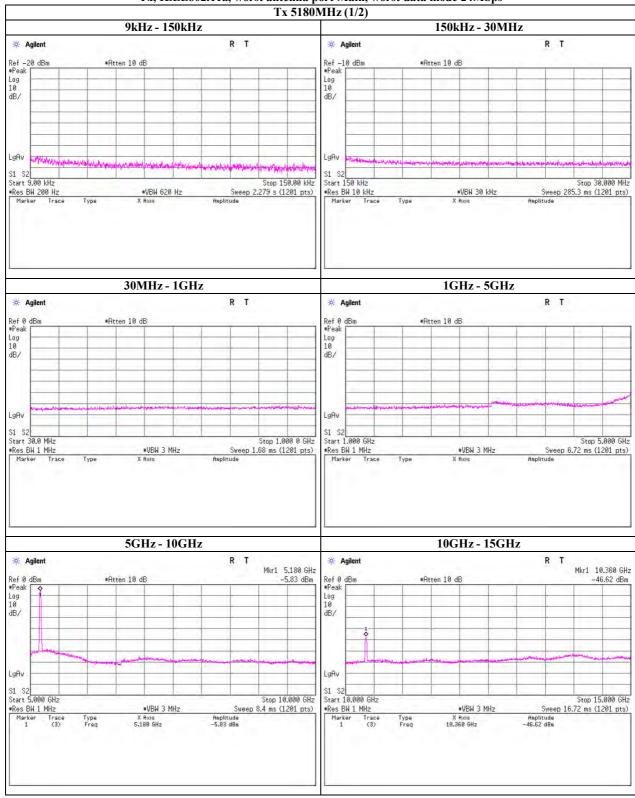
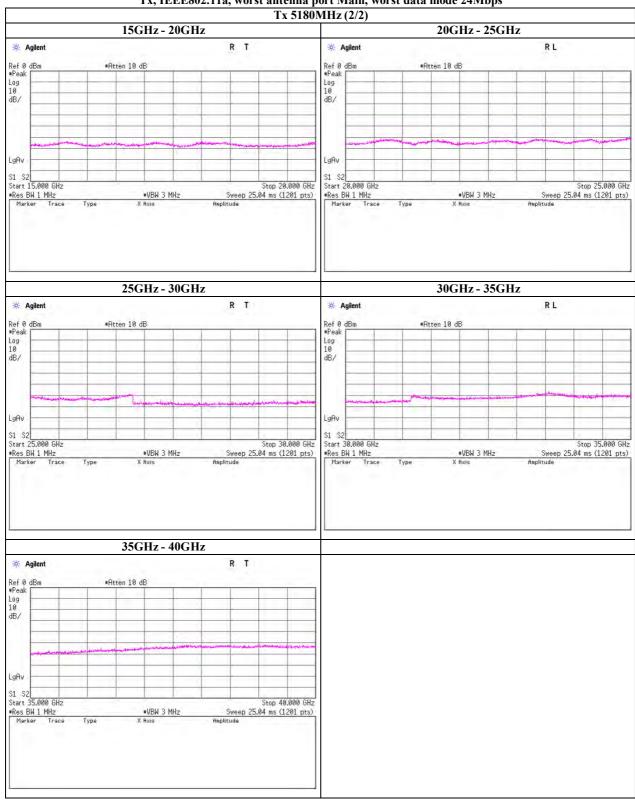
Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps



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Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps

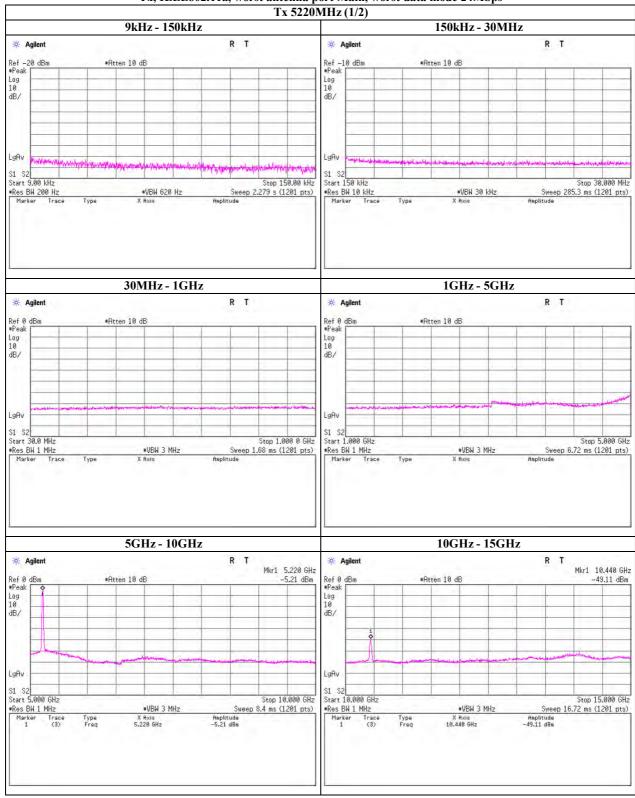


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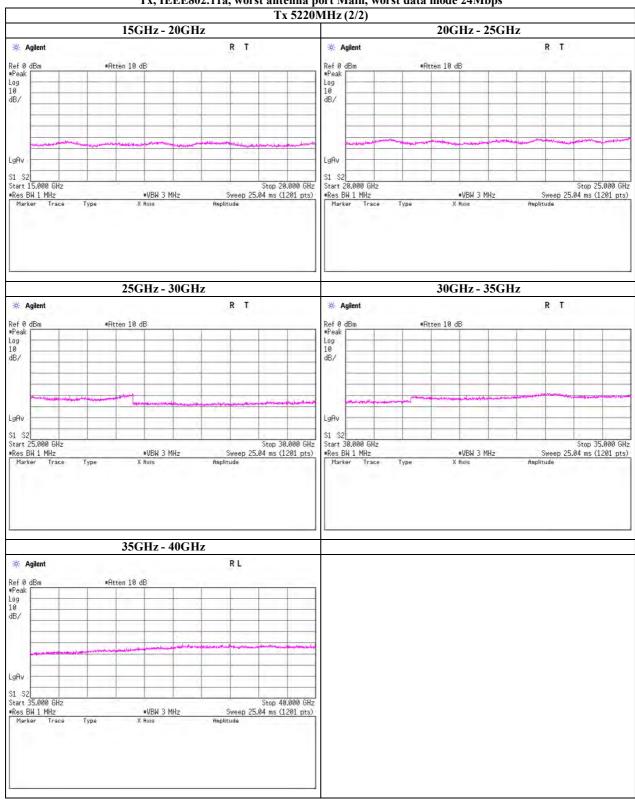
Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps



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Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps

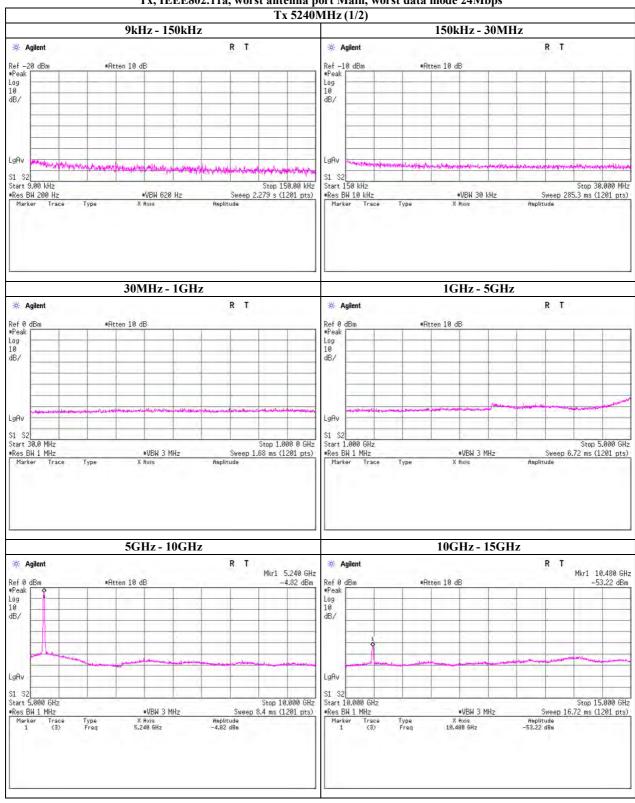


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Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps

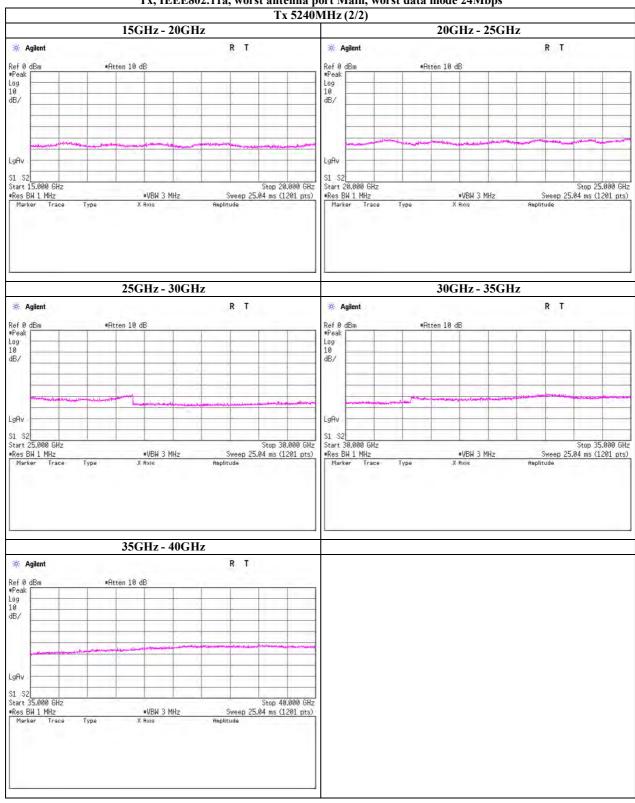


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Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps

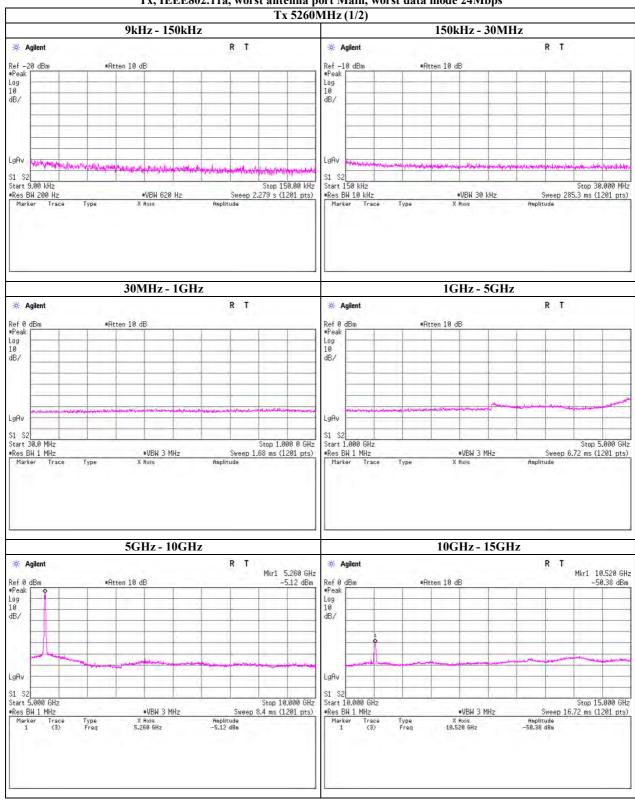


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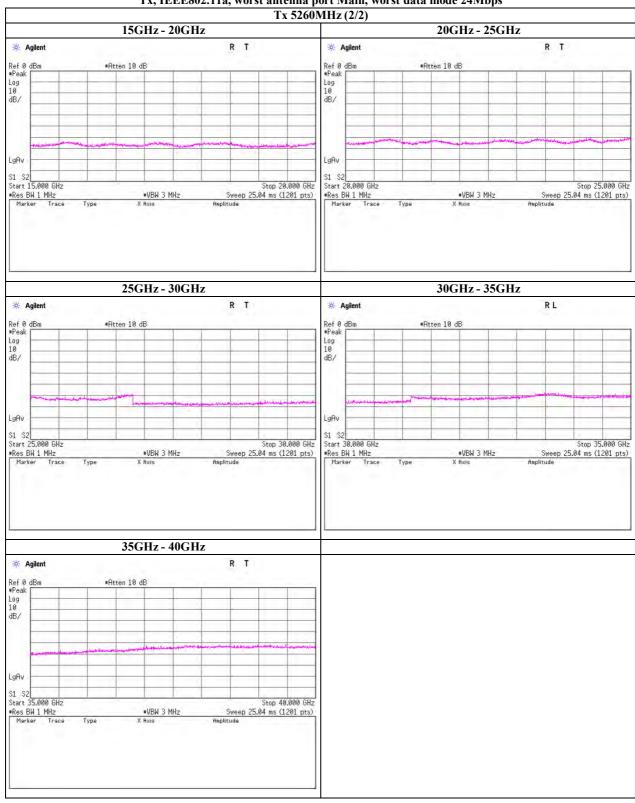
Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps



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Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps

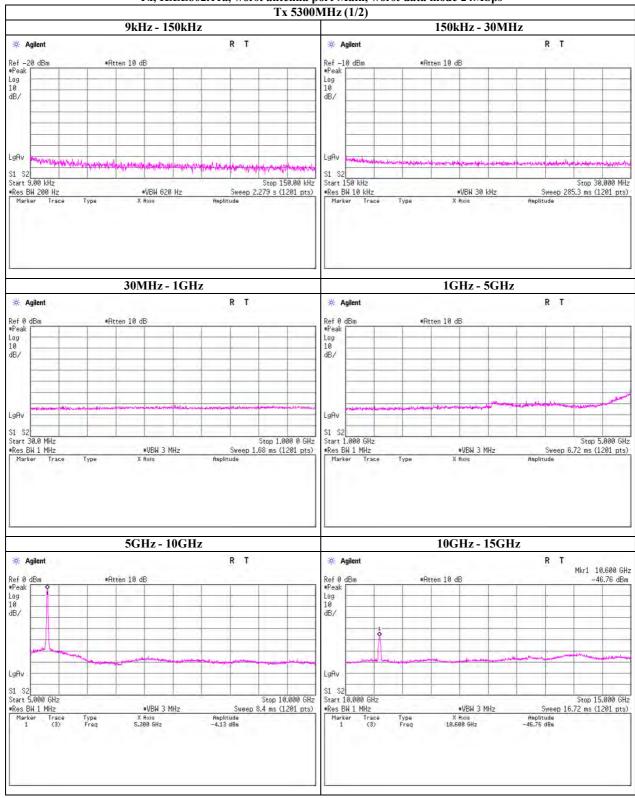


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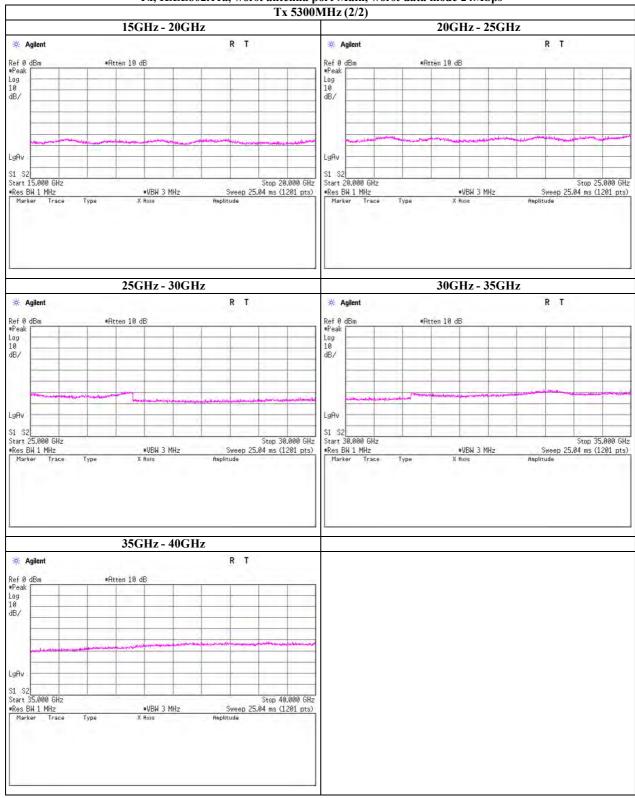
Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps



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Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps

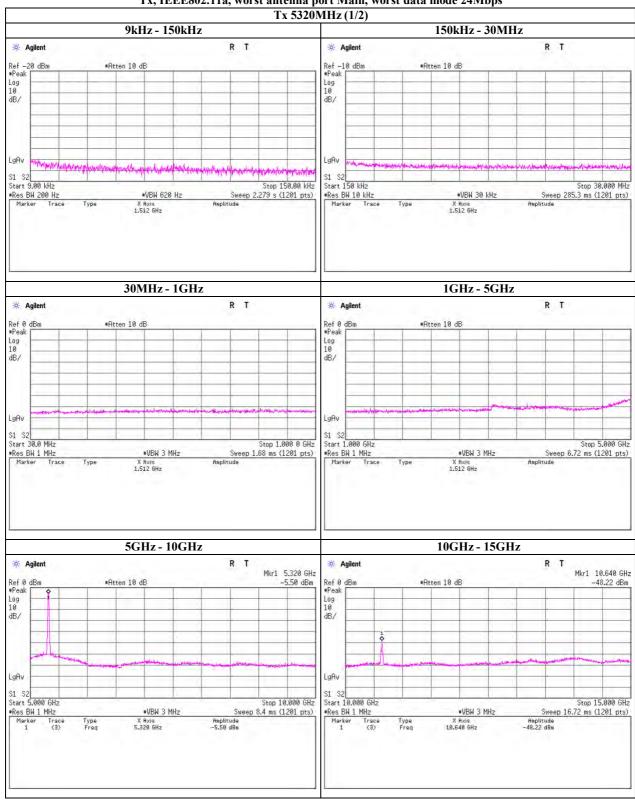


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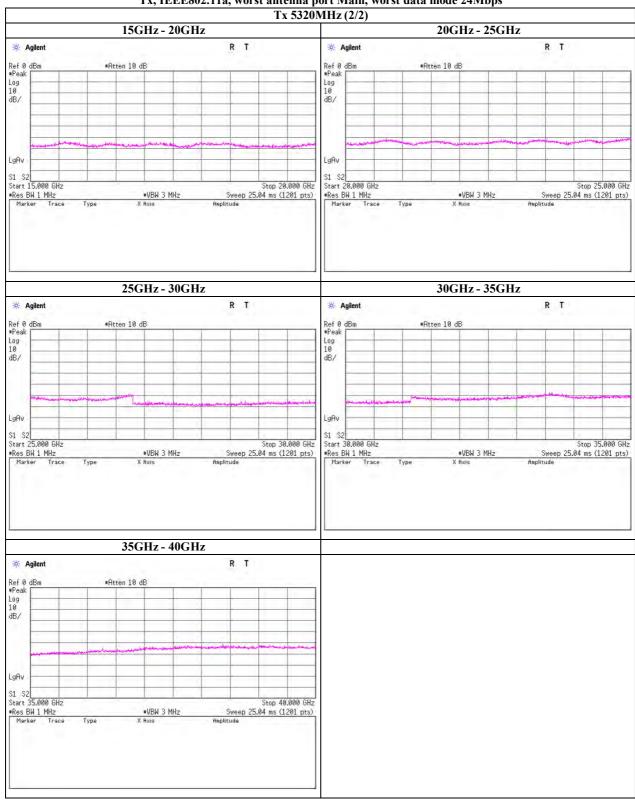
Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps



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Tx, IEEE802.11a, worst antenna port Main, worst data mode 24Mbps

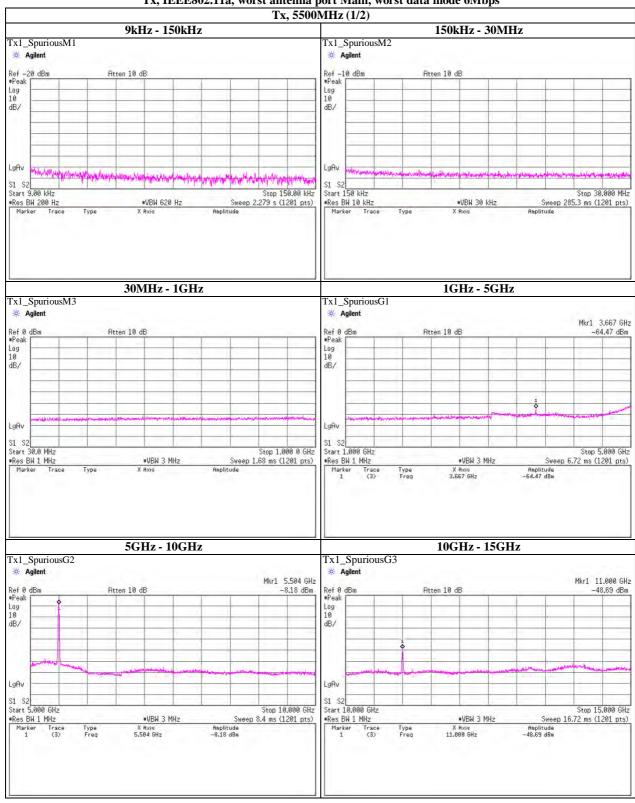


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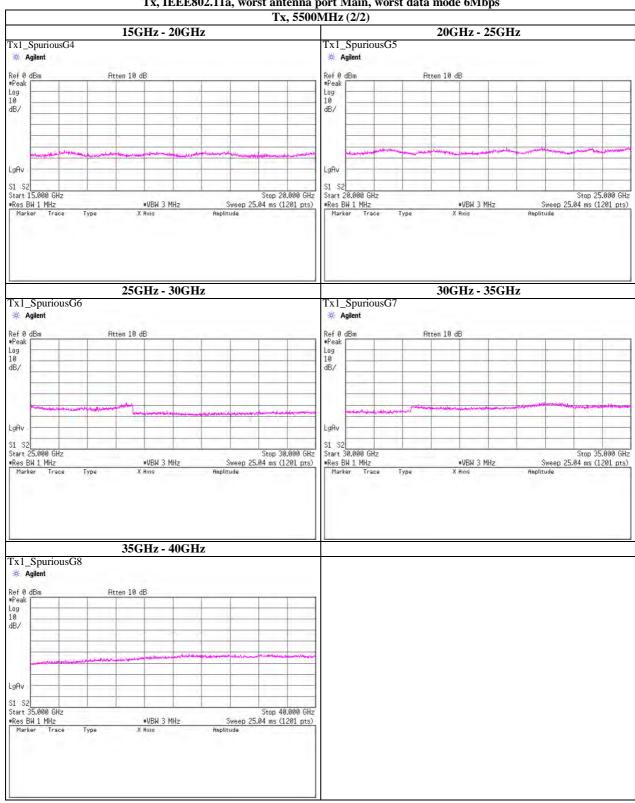
Tx, IEEE802.11a, worst antenna port Main, worst data mode 6Mbps



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Tx, IEEE802.11a, worst antenna port Main, worst data mode 6Mbps

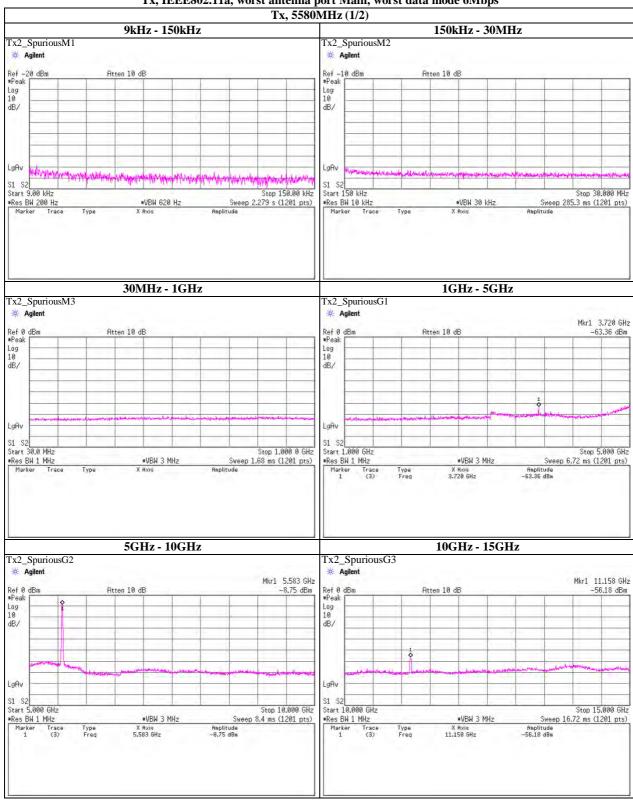


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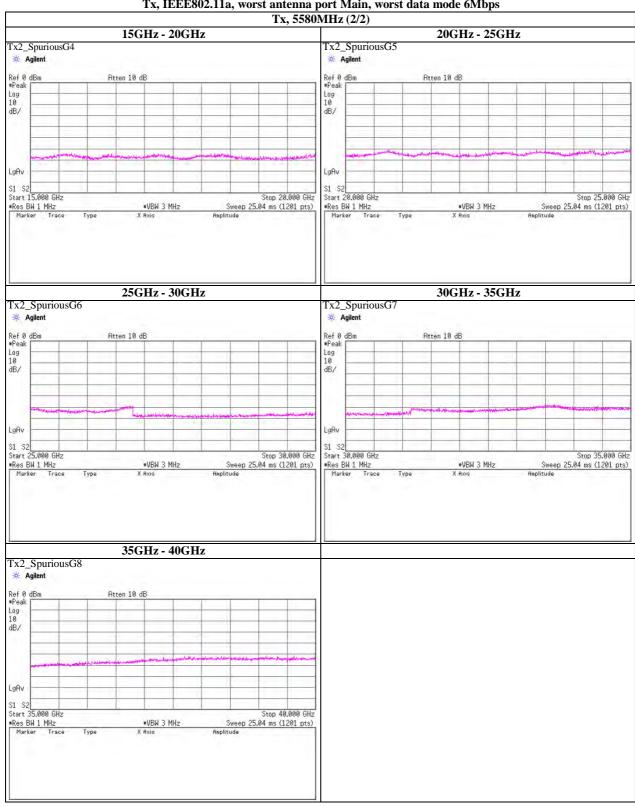
Tx, IEEE802.11a, worst antenna port Main, worst data mode 6Mbps



UL Japan, Inc. Shonan EMC Lab.

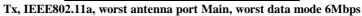
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

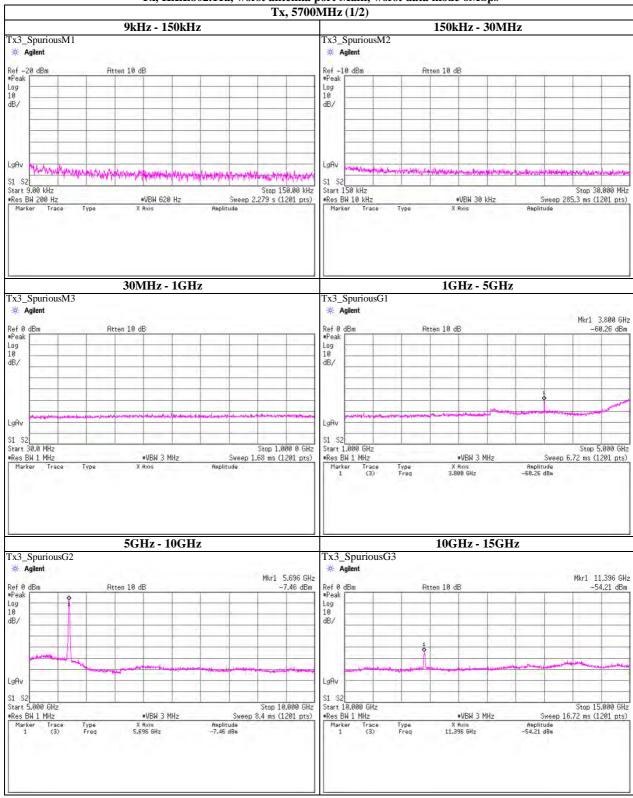
Tx, IEEE802.11a, worst antenna port Main, worst data mode 6Mbps



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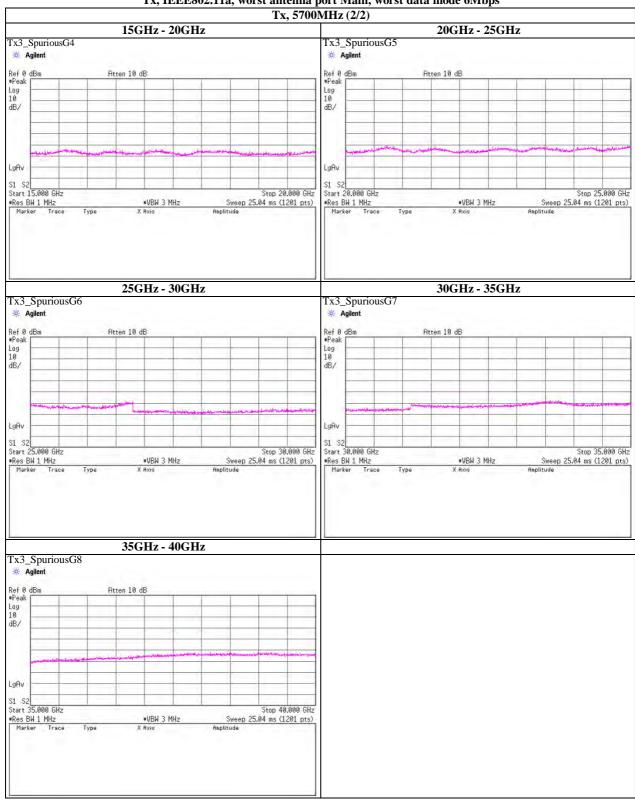




UL Japan, Inc. Shonan EMC Lab.

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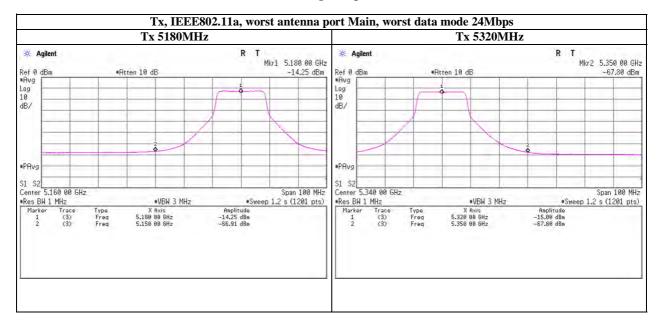
<u>Spurious emission (Conducted)</u> Tx, IEEE802.11a, worst antenna port Main, worst data mode 6Mbps

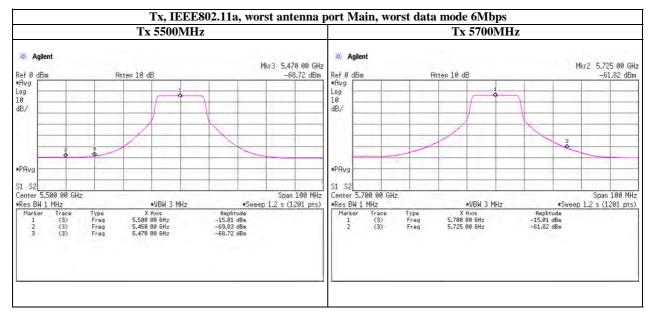


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Band Edge compliance





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Power Density

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room

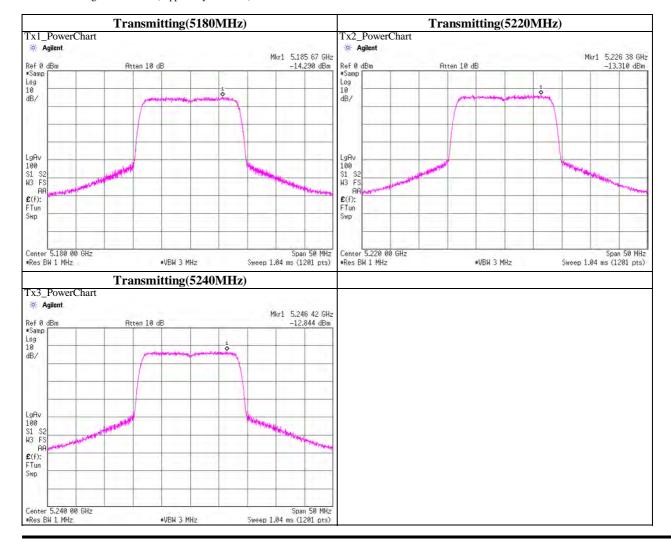
Date August 25, 2011
Temperature / Humidity 27deg.C , 60%RH
Engineer Tatsuya Arai

Mode Tx, IEEE802.11a, PN9, worst antenna port Main, worst data mode 24Mbps

Ch. Freq.	Freq.	Reading	Cable	Atten.	Result	Limit	Margin
	Reading		Loss				
[MHz]	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[dBm]	[dB]
5180.0000	5185.67	-14.29	2.54	9.64	-2.11	4.00	6.11
5220.0000	5226.38	-13.31	2.60	9.63	-1.08	4.00	5.08
5240.0000	5246.42	-12.84	2.60	9.62	-0.62	4.00	4.62

Sample Calculation:

 $Result = Reading + Cable\ Loss\ (supplied\ by\ customer) + Atten.\ Loss$



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Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Power Density

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room

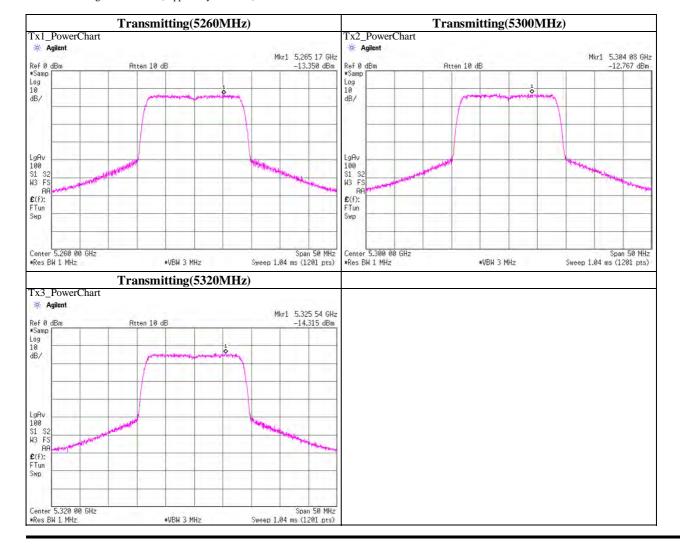
Date August 25, 2011
Temperature / Humidity 27deg.C , 60% RH
Engineer Tatsuya Arai

Mode Tx, IEEE802.11a, PN9, worst antenna port Main, worst data mode 24Mbps

Ch. Freq.	Freq.	Reading	Cable	Atten.	Result	Limit	Margin
	Reading		Loss				
[MHz]	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[dBm]	[dB]
5260.0000	5265.17	-13.35	2.59	9.62	-1.14	11.00	12.14
5300.0000	5304.08	-12.77	2.54	9.61	-0.62	11.00	11.62
5320.0000	5325.54	-14.32	2.52	9.60	-2.20	11.00	13.20

Sample Calculation:

 $Result = Reading + Cable\ Loss\ (supplied\ by\ customer) + Atten.\ Loss$



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Power Density

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

 $\begin{array}{ll} \text{Date} & \text{November 17, 2011} \\ \text{Temperature / Humidity} & \text{23deg.C} & \text{, 45\%RH} \end{array}$

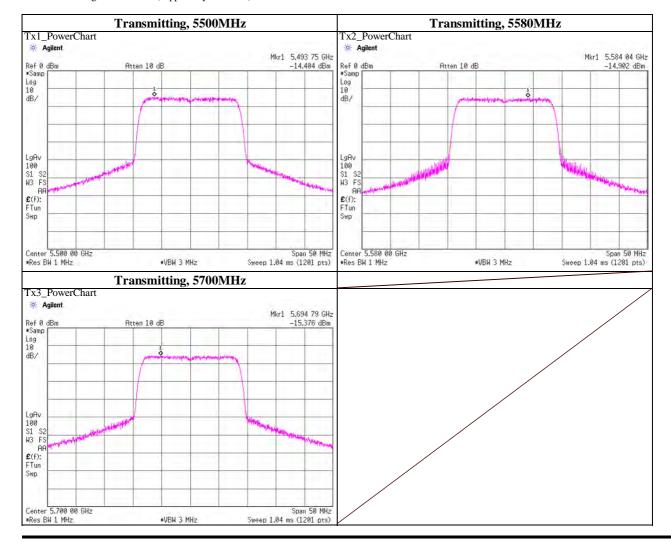
Engineer Tatsuya arai

Mode Tx, IEEE802.11a, PN9, worst antenna port Main, worst data mode 6Mbps

Ch. Freq.	Freq.	Reading	Cable	Atten.	Result	Limit	Margin
	Reading		Loss				
[MHz]	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[dBm]	[dB]
5500.0000	5493.75	-14.40	2.68	9.56	-2.16	11.00	13.16
5580.0000	5584.04	-14.90	2.58	9.57	-2.75	11.00	13.75
5700.0000	5694.79	-15.38	2.65	9.60	-3.13	11.00	14.13

Sample Calculation:

 $Result = Reading + Cable\ Loss\ (supplied\ by\ customer) + Atten.\ Loss$



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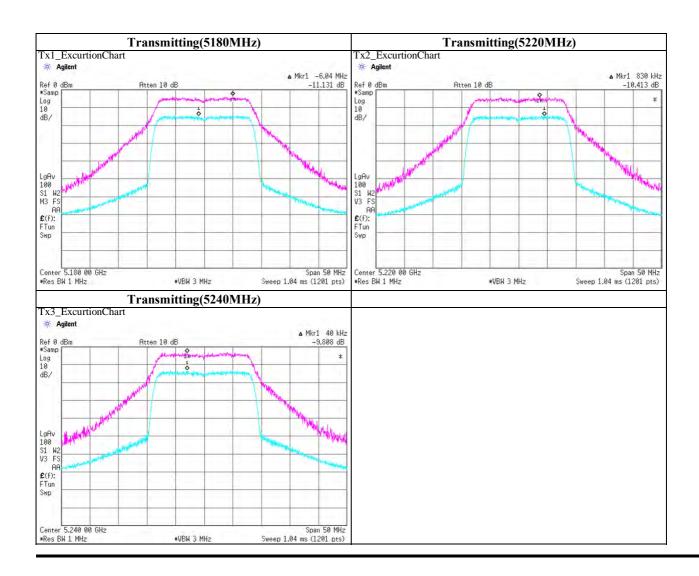
Peak Excursion Ratio

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room

Date August 25, 2011
Temperature / Humidity 27deg.C , 60% RH
Engineer Tatsuya Arai

Mode Tx, IEEE802.11a, PN9, worst antenna port Main, worst data mode 24Mbps

Ch. Freq.	Peak Power	Limit	Margin
	Excursion		
[MHz]	[dB]	[dB]	[dB]
5180.0000	11.13	=<13.0	1.87
5220.0000	10.41	=<13.0	2.59
5240.0000	9.81	=<13.0	3.19



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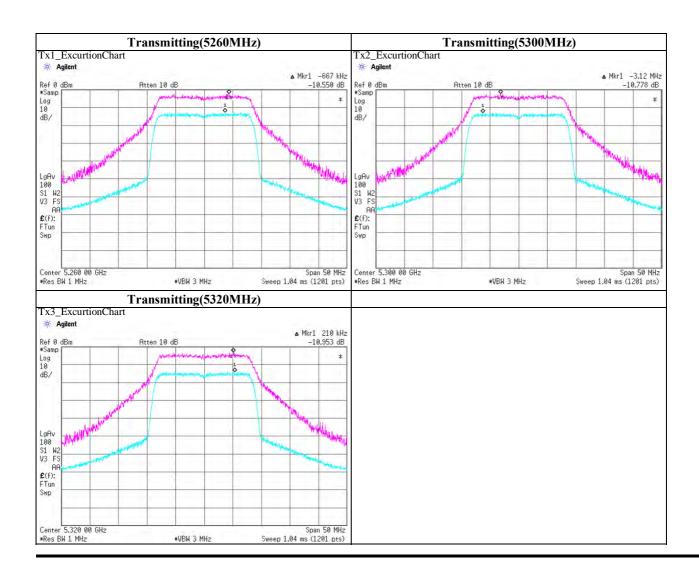
Peak Excursion Ratio

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room

Date August 25, 2011
Temperature / Humidity 27deg.C , 60% RH
Engineer Tatsuya Arai

Mode Tx, IEEE802.11a, PN9, worst antenna port Main, worst data mode 24Mbps

Ch. Freq.	Peak Power	Limit	Margin
	Excursion		
[MHz]	[dB]	[dB]	[dB]
5260.0000	10.55	=<13.0	2.45
5300.0000	10.78	=<13.0	2.22
5320.0000	10.95	=<13.0	2.05



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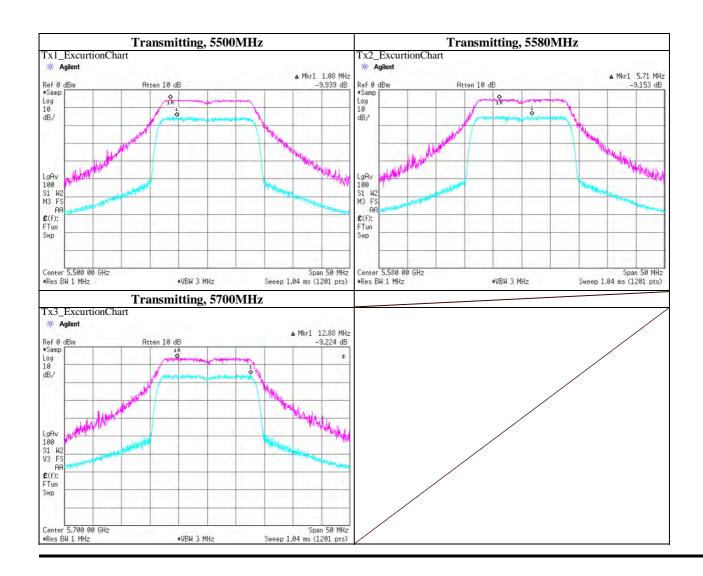
Peak Excursion Ratio

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 17, 2011
Temperature / Humidity 23deg.C , 45%RH
Engineer Tatsuya arai

Mode Tx, IEEE802.11a, PN9, worst antenna port Main, worst data mode 6Mbps

Ch. Freq.	Peak Power	Limit	Margin
	Excursion		
[MHz]	[dB]	[dB]	[dB]
5500.0000	-9.94	=<13.0	22.94
5580.0000	-9.15	=<13.0	22.15
5700.0000	-9.22	=<13.0	22.22



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Test Report No :31HE0102-SH-04-A

APPENDIX 2 Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SSA-03	Spectrum Analyzer	Agilent	E4448A	MY48250152	AT	2010/11/16 * 12
SCC-G11	Coaxial Cable	Suhner	SUCOFLEX 102	31595/2	AT	2011/03/23 * 12
SAT10-09	Attenuator	Weinschel Corp.	54A-10	W5692	AT	2010/11/24 * 12
SOS-09	Humidity Indicator	A&D	AD-5681	4061484	AT	2011/03/02 * 12
SAF-06	Pre Amplifier	TOYO Corporation	TPA0118-36	1440491	RE	2011/07/19 * 12
SCC-G03	Coaxial Cable	Suhner	SUCOFLEX 104A	46499/4A	RE	2011/04/28 * 12
SCC-G23	Coaxial Cable	Suhner	SUCOFLEX 104	297342/4	RE	2011/05/27 * 12
SHA-03	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-739	RE	2011/08/28 * 12
SOS-05	Humidity Indicator	A&D	AD-5681	4062518	RE	2011/02/23 * 12
SSA-02	Spectrum Analyzer	Agilent	E4448A	MY48250106	RE	2011/03/07 * 12
SJM-10	Measure	PROMART	SEN1935	-	RE	_
COTS-SEMI-1	EMI Software	TSJ	TEPTO-DV(RE,CE, RFI,MF)	-	RE	-
SAT10-05	Attenuator(above1GHz)	Agilent	8493C-010	74864	RE	2010/12/15 * 12
SFL-03	Highpass Filter	MICRO-TRONICS	HPM50112	028	RE	2010/12/15 * 12
SAF-02	Pre Amplifier	SONOMA	310N	290212	RE	2011/02/17 * 12
SAT6-02	Attenuator	JFW	50HF-006N	-	RE	2011/02/17 * 12
SAT3-02	Attenuator	JFW	50HF-003N	[-	RE	2011/02/17 * 12
SBA-02	Biconical Antenna	Schwarzbeck	BBA9106	91032665	RE	2011/09/10 * 12
SCC-B1/B3/B5 /B7/B8/B13/S RSE-02	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhne r/Suhner/Suhner/Suhn er/TOYO	8D2W/12DSFA/14 1PE/141PE/141PE /141PE/NS4906		RE	2011/04/28 * 12
SCC-B2/B4/B6 /B7/B8/B13/S RSE-02	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhne r/Suhner/Suhner/Suhn er/TOYO	8D2W/12DSFA/14 1PE/141PE/141PE /141PE/NS4906	-/0901-270(RF Selector)	RE	2011/04/28 * 12
SLA-02	Logperiodic Antenna	Schwarzbeck	UHALP9108A	UHALP 9108-A 0893	RE	2011/09/10 * 12
SOS-03	Humidity Indicator	A&D	AD-5681	4063325	RE	2011/02/23 * 12
STR-02	Test Receiver	Rohde & Schwarz	ESCI	100575	RE	2011/08/04 * 12
SJM-02	Measure	KOMELON	KMC-36	-	RE	_
SAEC-02(NSA)	Semi-Anechoic Chamber	TDK	SAEC-02(NSA)	2	RE	2011/09/25 * 12

The expiration date of the calibration is the end of the expired month $\ .$

As for some calibrations performed after the tested dates , those test equipment have been controlled by means of an unbroken chains of calibrations .

All equipment is calibrated with valid calibrations . Each measurement data is traceable to the national or international standards .

Test Item:

RE: Radiated emission,

AT: Antenna terminal conducted test

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Test Report No :31HE0102-SH-04-A

APPENDIX 2 Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SHA-05	Horn Antenna	ETS LINDGREN	3160-09	LM4210	RE	2011/03/15 * 12
SHA-06	Horn Antenna	ETS LINDGREN	3160-10	LM3459	RE	2011/03/15 * 12
SCC-G18	Coaxial Cable	Suhner	SUCOFLEX 104A	46292/4A	RE	2011/03/16 * 12
SCC-G19	Coaxial Cable	Suhner	SUCOFLEX 102A	1188/2A	RE	2011/03/16 * 12
SAF-09	Pre Amplifier	TOYO Corporation	HAP18-26W	00000018	RE	2011/03/16 * 12
SAF-10	Pre Amplifier	TOYO Corporation	HAP26-40W	00000010	RE	2011/03/16 * 12
SSG-02	Signal Generator	Agilent	E8257D-540	MY48051404	RE	2011/03/01 * 12
SCC-G16	Coaxial Cable	Suhner	SUCOFLEX 102	32704/2	RE	2011/03/23 * 12
SHA-RS01	Horn Antenna	Schwarzbeck	BBHA9120D	770	RE	2011/08/11 * 12
SHA-07	Horn Antenna	ETS·LINDGREN	3116	00108256	RE	2011/03/15 * 12
						İ

The expiration date of the calibration is the end of the expired month .

As for some calibrations performed after the tested dates , those test equipment have been controlled by means of an unbroken chains of calibrations .

All equipment is calibrated with valid calibrations . Each measurement data is traceable to the national or international standards .

Test Item:

RE: Radiated emission,

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